EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	34	((goodness near fit$3) (curve near fitt$3) (fitt$3 near1 goodness) (foodness near2 measur$4)) same ((control$3 near limit$1) (threshold near1 controL$3) (control$3 near threshold) (limit$3 near value$1))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/06 14:46
L2	1	(((goodness near fit$3) (curve near fitt$3) (fitt$3 near1 goodness) (foodness near2 measur$4)) with histor$4) same ((control$3 near limit$1) (threshold near1 controL$3) (control$3 near threshold) (limit$3 near value$1))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/06 14:47
L3	1	((((goodness near fit$3) (curve near fitt$3) (fitt$3 near1 goodness) (foodness near2 measur$4)) with histor$4) same ((control$3 near limit$1) (threshold near1 controL$3) (control$3 near threshold) (limit$3 near value$1))).clm.	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/06 14:47
L4	1	("5574890").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 14:51
L5	2	(goodness near fit$4) same ((resistance capacitance) with value$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 14:57
L6	0	(goodness near fit$4) near ((resistance capacitance) with value$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 14:59
L7	0	("5,987,3981").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:00
L8	1	("5,987,398").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:08
L9	0	("k6,403,3891").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:08
L10	0	("6,403,3891").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:08
L11	1	("6,403,389").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:59
L13	1	(goodness near1 fit$3) same ((usage us$3) near (monitor$3 and control$3 and process$3)) and structure$1	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:49
L14	0	(curve near fitt$3) with (screen$3 near device$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:00
L15	77	(curve near fitt$3) and (screen$3 near device$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:00

L16	400	(curve near fitt$3) and ((screen$3 near device$1) (detect$3 with defect$1))	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:00
L17	5	(curve near fitt$3) and ((screen$3 near device$1) and (detect$3 with defect$1))	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:01
L18	249	(curve near fitt$3) and (process$3 with (controL$3 monitor$3)) and (detect$3 with defect$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:03
L19	16	(curve near fitt$3) and (process$3 with (controL$3 monitor$3)) and (detect$3 with defect$1) and (goodness near fit$4)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:04
L20	44	(curve near fitt$3) and (process$3 with (controL$3 monitor$3)) and (detect$3 with defect$1) and ((goodness near1 (fit$4 measur$3)) (coefficient$1 near correlation$1))	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:12
L21	1	(curve near fitt$3) and (process$3 with (controL$3 monitor$3)) and (detect$3 with defect$1) and ((goodness near1 (fit$4 measur$3)) (coefficient$1 near correlation$1)) and (sheet$1 near (resistance resistivity))	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:07
L22	0	(curve near fitt$3) and (process$3 with (controL$3 monitor$3)) and (detect$3 with defect$1) and ((goodness near1 (fit$4 measur$3)) (coefficient$1 near correlation$1)) and (test$3 with (structure$1 wafer$1)) and (model$1base$1 with statistic$3)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 16:08
L26	1	("6403389").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 17:27
S1	583	(702/179).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 09:20
S2	7	S1 and (monitor$3 with defect$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 10:34
S3	6	(("6,403,389") or ("5,627,101") or ("5, 987j398") or ("5,883.437") or ("6,466,038") or ("5,514,974") or ("6,087,189") or ("5, 552,718")).PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 10:34
S4	7	(("6,403,389") or ("5,627,101") or ("5,987, 398") or ("5,883.437") or ("6,466,038") or ("5,514,974") or ("6,087,189") or ("5,552, 718")).PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 10:42
S5	1	("20030139908").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:36

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S6	1029	(CHARTERED with SEMICONDUCTOR)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:14
S7	0	S6 and (lim near sheldon)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:14
S8	13	(sheldon with lim)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:14
S9	1	S8 and ((monitor$3 near defect$1) (goodness near (curve$1 fit$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:15
S10	2	S6 and ((monitor$3 near defect$1) (goodness near (curve$1 fit$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:17
S11	2339	((monitor$3 near defect$1) (goodness near (curve$1 fit$3))) not (S8 S6)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:17
S12	2339	((monitor$3 near defect$1) (goodness near (curve$1 fit$3))) not S8 not S6	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:17
S13	2341	((monitor$3 near defect$1) (goodness near (curve$1 fit$3))) not S8	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:17
S14	2340	((monitor$3 near defect$1) (goodness near (curve$1 fit$3))) not S6	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:27
S15	0	((monitor$3 near defect$1) and (goodness near (curve$1 fit$3))) not S8	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:18
S16	0	((monitor$3 near defect$1) same (goodness near (curve$1 fit$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:28
S17	1	((monitor$3 near defect$1) and (goodness near (curve$1 fit$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 11:28
S18	161	(goodness near (curve$1 fit$3)) and (control$3 adj process$3)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:54
S19	452	(700/110).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:33
S20	341	(700/109).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:33
S21	0	S18 and S19	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:33
S22	0	S18 and S20	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:33

S23	2	S18 and S1	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 14:57
S25	0	(10/164091).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 11:47
S26	1	"10164091"	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 13:43
S27	1	("6665577").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 13:43
S28	1	S27 and calculat$3 and (goodness near fit$3)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 13:43
S29	441	(goodness near (curve$1 fit$3)) same calculat$3	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:23
S30	18	(goodness near (curve$1 fit$3)) same calculat$3 same monitor$3	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:23
S31	2	(goodness near (curve$1 fit$3)) same calculat$3 same monitor$3 same regression$1	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:24
S32	56	(goodness near (curve$1 fit$3)) same calculat$3 same regression$1	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:32
S33	20	calculat$3 with (goodness near fit$3 near value$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:34
S34	5	(calculat$3 with (goodness near fit$3 near value$1)) and (curve$1 near fit$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:33
S35	36	("4475122" | "4567610" | "4736109" | "4823393" | "4945914" | "5063603" | "5189292" | "5241166" | "5245165" | "5260556" | "5363212" | "5475468" | "5506936" | "5515451" | "5572596").PN. OR ("5845008").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/05 14:41
S36	96	monitor$3 with (process$3 near stability)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:48
S37	0	(monitor$3 with (process$3 near stability)) same (curve$1 near fit$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:42
S38	1	(monitor$3 with (process$3 near stability)) and (goodness near fit$4)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:42
S39	1	(monitor$3 with (process$3 near stability)) and (fit$3 with curve$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:43

S40	3	(monitor$3 with (process$3 near stability)) and (fit$3 with value$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:46
S41	1	(monitor$3 with (process$3 near stability)) and (fit$3 with value$1) and (linear with regression$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:43
S42	0	(monitor$3 with (process$3 near stability)) and (coefficient near relat$3)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:47
S43	0	(goodness near1 fit with regress$4) near calculat$3	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:48
S44	21	(goodness near1 fit with regress$4) same calculat$3	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:49
S45	12	(goodness near1 fit with regress$4) and (degree near1 freedom)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:49
S46	8	(goodness near1 fit with regress$4) and (degree near1 freedom) and (statistic$3 with regress$3)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 14:53
S47	19	(goodness near (curve$1 fit$3)) and (control$3 adj process$3) and (correlat$3 with coefficient$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 16:54
S48	328	(statistic$3 near analys$3) and (goodness near (curve$1 fit$4)) and (control$3 monitor$3 with device$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 16:54
S49	23	((statistic$3 near analys$3) and (goodness near (curve$1 fit$4)))same (control$3 monitor$3 with device$1)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 16:55
S50	0	((statistic$3 near analys$3) and (goodness near (curve$1 fit$4))) same (process$3 adj controL$3)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 16:55
S51	0	((statistic$3 near analys$3) and (goodness near (curve$1 fit$4))) with (process$3 adj controL$3)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 16:56
S52	9	(goodness near (curve$1 fit$4)) same (process$3 adj controL$3)	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 17:02
S53	1	(semiconductor$1 near device$1) same (goodness near (fit$3 measur$5))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/05 17:02
S54	21	((fit$3 near measurement$1) with (usage$1 us$3)) same device$1	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:22
S55	2	(measur$3 near device$1) same (goodness near (fit$3 measurement$1 measur$4 control$3))	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:22
S56	1	(goodness near1 fit$3) same ((usage us$3) near (monitor$3 and control$3 and process$3))	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 15:48

S57	11	(goodness adj fit$1) and ((independent near variable$1) with device$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:27
S58	43	model$1base$1 near monitor$3	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:45
S59	0	(model$1base$1 near monitor$3) and (goodness near1 fit$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:37
S60	0	(model$1base$1 near monitor$3) and (goodness with curve$1)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:37
S61	0	(model$1base$1 near monitor$3) and (coeffiecient$1 with correlat$3)	US-PGPUB; USPAT; USOCR	OR	OFF	2006/07/06 09:37
S62	4	((manipulat$3 calculat$3 form$3) with (goodness near1 (fit$3 measur$4 statistical$3))) and ((semiconductor$1 wafer$1) with (form$3 near process$3))	US-PGPUB; USPAT; USOCR	OR	ON	2006/07/06 14:44